

Notice of References Cited	Application/Control No. 10/655,767		Applicant(s)/Patent Under Reexamination YAO ET AL.	
	Examiner Derek L. Dupuis		Art Unit 2883	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0181900 A1	12-2002	Loch et al.	385/92
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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